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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/651,424	JAKUBOWSKI ET AL.	
Examiner	Art Unit	_
Tongoc Tran	2134	

	SEARCHED		
Class	Subclass	Date	Examiner
380	28, 29	1/26/2006	π
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EIC	1/19/2006	π
Consult: S. Moise; SPE 2137 B. Lanier AU: 2132	1/19/2006	т
Consult: K. Vu: SPE 2135	1/5/2006	тт
East	1/20/2006	π